

Search Notes

Application/Control No.

10/506,492

Examiner

Rhonda S. Peace

Applicant(s)/Patent under
Reexamination

USHIRO ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	34	10/5/2005	RSP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history notes (keyword search across all classes)	10/5/2005	RSP
Consultation with Primary Examiner John D. Lee	10/6/2005	RSP
Search of IEEE database (TC 2800) using terms DLC, diamond-like-carbon, diffraction films and gratings	10/6/2005	RSP